

2N5088/5089

NPN EPITAXIAL SILICON TRANSISTOR

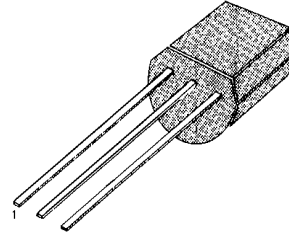
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: V_{CE0} = 2N5088: 30V
2N5089: 25V
- Collector Dissipation: P_C (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CE0}	30	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	35			V
			30			V
* Collector-Emitter Breakdown Voltage	BV_{CE0}	$I_C=1\text{mA}, I_B=0$	30			V
			25			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$			50	nA
		$V_{CB}=15\text{V}, I_E=0$			5	nA
Base Cut-off Current	I_{EBO}	$V_{BE}=3\text{V}, I_C=0$			50	nA
		$V_{BE}=4.5\text{V}, I_C=0$			100	nA
* DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	300		900	
		$V_{CE}=5\text{V}, I_C=1\text{mA}$	400		1,200	
		* $V_{CE}=5\text{V}, I_C=10\text{mA}$	350			
			450			
			300			
			400			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.5	V
* Base-Emitter Saturation Voltage	$V_{BE(on)}$	$I_C=10\text{mA}, V_{CE}=5\text{V}$			0.8	V
Current-Base Capacitance	C_{OB}	$V_{CB}=5\text{V}, I_E=0$ $f=100\text{MHz}$			4	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=500\mu\text{A}$	50			MHz
Noise Figure	N_F	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$ $R_S=10k\Omega$ $f=10\text{Hz to } 15.7\text{KHz}$			3	dB
					2	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

